

**Search Notes**

Application/Control No.

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Examiner

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Applicant(s)/Patent under  
Reexamination

HAGIWARA, AKIRA

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	211.99	7/16/2007	NT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	7/16/2007	NT
Text search classes 348, 378 and 705 (see search history printout)	7/16/2007	NT